Notice of References Cited Application/Control No. 10/729,558 Examiner Krisna Lim Applicant(s)/Patent Under Reexamination YOON ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,127,736	10-2006	Kondo et al.	725/93
*	В	US-6,654,769	11-2003	Ito et al.	707/200
*	O	US-2006/0031188	02-2006	Lara et al.	707/001
*	D	US-2002/0112247	08-2002	Horner et al.	725/112
*	Е	US-2003/0161615	08-2003	Tsumagari et al.	386/95
*	F	US-2006/0242161	10-2006	Ten Kate et al.	707/100
	G	US-			
	Ŧ	US-			
	_	US-			
	7	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.